

## SEMITOP<sup>®</sup> 2

### **IGBT** Module

#### SK50GAL065 SK50GAR065

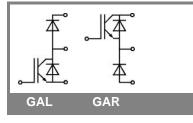
Preliminary Data

#### Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure
- (NPT-Non-Punch-Through IGBT) • Low tail current with low
- temperature dependenceLow treshold voltage

### **Typical Applications\***

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



Absolut	te Maximum Ratings		T <sub>s</sub> = 2	5 °C, unless otherwise	e specified
Symbol	Conditions			Values	Units
IGBT					
V <sub>CES</sub>	$T_{j} = 25 \text{ °C}$ $T_{j} = 125 \text{ °C}$			600	V
I <sub>C</sub>	T <sub>j</sub> = 125 °C	T <sub>s</sub> = 25 °C		54	А
		T <sub>s</sub> = 80 °C		40	А
I <sub>CRM</sub>	I <sub>CRM</sub> = 2 x I <sub>Cnom</sub>			60	А
V <sub>GES</sub>				± 20	V
t <sub>psc</sub>	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 300 \; V; \; V_{GE} \leq 20 \; V; \\ V_{CES} < 600 \; V \end{array}$	T <sub>j</sub> = 125 °C		10	μs
Inverse	Diode				
۱ <sub>F</sub>	T <sub>j</sub> = 150 °C	T <sub>s</sub> = 25 °C		57	A
		T <sub>s</sub> = 80 °C		38	А
I <sub>FRM</sub>	I <sub>FRM</sub> = 2 x I <sub>Fnom</sub>			100	А
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		440	А
Freewh	eeling Diode				
I <sub>F</sub>	T <sub>j</sub> = 150 °C	T <sub>s</sub> = 25 °C		57	А
		T <sub>s</sub> = 80 °C		38	А
I <sub>FRM</sub>				100	А
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		440	А
Module					
I <sub>t(RMS)</sub>					А
T <sub>vj</sub>				-40 +150	°C
T <sub>stg</sub>				-40 +125	°C
V <sub>isol</sub>	AC, 1 min.			2500	V

Characteristics T <sub>s</sub> =		25 °C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
V <sub>GE(th)</sub>	$V_{GE}$ = $V_{CE}$ , $I_C$ = 1,4 mA		3	4	5	V
I <sub>CES</sub>	$V_{GE}$ = 0 V, $V_{CE}$ = $V_{CES}$	T <sub>j</sub> = 25 °C			0,0044	mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 25 °C			240	nA
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		1,1		V
		T <sub>j</sub> = 125 °C		1,1		V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		15		mΩ
		T <sub>j</sub> = 125°C		19		mΩ
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 60 A, V <sub>GE</sub> = 15 V			2	2,5	V
		T <sub>j</sub> = 125°C <sub>chiplev.</sub>		2,2		V
C <sub>ies</sub>				3,2		nF
C <sub>oes</sub>	$V_{CE}$ = 25, $V_{GE}$ = 0 V	f = 1 MHz		0,3		nF
C <sub>res</sub>				0,18		nF
t <sub>d(on)</sub>				60	80	ns
t,	R <sub>Gon</sub> = 16 Ω	V <sub>CC</sub> = 300V		30	40	ns
É <sub>on</sub>		I <sub>C</sub> = 40A		1,1	1,4	mJ
t <sub>d(off)</sub>	$R_{Goff}$ = 16 $\Omega$	T <sub>j</sub> = 125 °C		220	280	ns
t <sub>f</sub>		V <sub>GE</sub> =±15V		20	26	ns
E <sub>off</sub>				0,7	0,9	mJ
R <sub>th(j-s)</sub>	per IGBT				0,85	K/W

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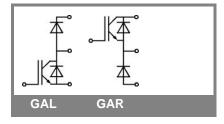
#### **Typical Applications\***

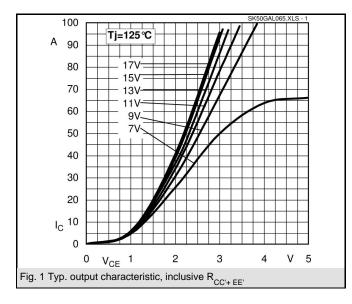
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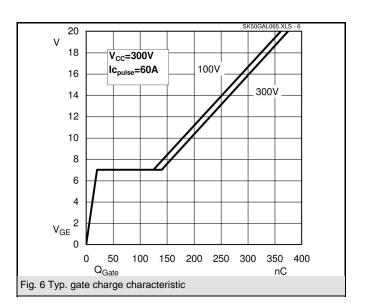
Characteristics						
Symbol	Conditions		min.	typ.	max.	Units
Inverse D						
$V_F = V_{EC}$	I <sub>Fnom</sub> = 30 A; V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>		1,3	1,5	V
		T <sub>j</sub> = 150 °C <sub>chiplev.</sub>		1,2	1,45	V
V <sub>F0</sub>		T <sub>j</sub> = 25 °C				V
		T <sub>j</sub> = 125 °C		0,85	0,9	V
r <sub>F</sub>		T <sub>i</sub> = 25 °C				mΩ
		T <sub>i</sub> = 125 °C		9	16	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 30 A	T <sub>i</sub> = 125 °C		22		Α
Q <sub>rr</sub>	di/dt = -500 A/µs	ī		2,2		μC
E <sub>rr</sub>	V <sub>CC</sub> = 300V			0,2		mJ
R <sub>th(j-s)D</sub>	per diode				1,2	K/W
	eling Diode					•
V <sub>F</sub> = V <sub>EC</sub>	I <sub>Fnom</sub> = 30 A; V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>		1,3	1,5	V
		T <sub>j</sub> = 125 °C <sub>chiplev.</sub>		1,2	1,45	V
V <sub>F0</sub>		T <sub>j</sub> = 125 °C		0,85	0,9	V
r <sub>F</sub>		T <sub>j</sub> = 125 °C		9	16	V
I <sub>RRM</sub>	I <sub>F</sub> = 30 A	T <sub>i</sub> = 125 °C		22		Α
Q <sub>rr</sub>	di/dt = -500 A/µs	1		2,2		μC
E <sub>rr</sub>	V <sub>R</sub> =300V			0,2		mJ
R <sub>th(j-s)FD</sub>	per diode				1,2	K/W
M <sub>s</sub>	to heat sink				2	Nm
w				19		g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.



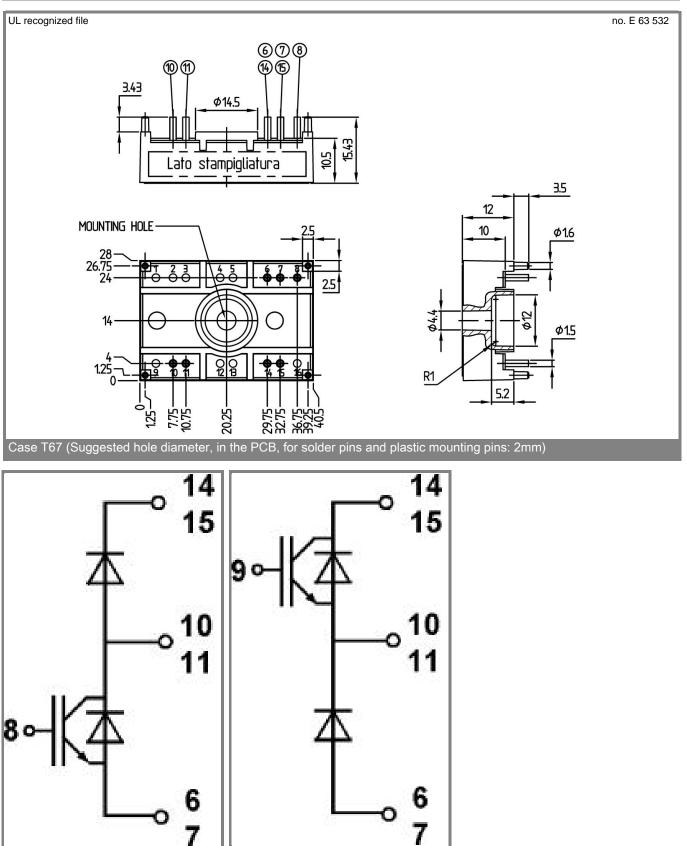




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GAR

Case T 67

GAL

Case T 67

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